

# Silicon Carbide (SiC) **MOSFET** - EliteSiC, 192 mohm, 1700 V, M1, TO-247-4L

# NVH4L200N170M1

#### **Features**

- Typ.  $R_{DS(on)} = 192 \text{ m}\Omega$  @  $V_{GS} = 20 \text{ V}$
- Ultra Low Gate Charge  $(Q_{G(tot)} = 31 \text{ nC})$
- High Speed Switching with Low Capacitance (Coss = 33 pF)
- 100% Avalanche Tested
- These Devices are Pb-Free and are RoHS Compliant

#### **Typical Applications**

- Automotive On Board Charger
- Automotive DC-DC Converter for EV/HEV

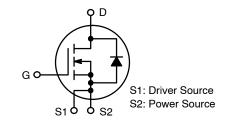
#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			$V_{DSS}$	1700	V
Gate-to-Source Voltage	1		$V_{GS}$	-15/+25	V
Recommended Operation Values of Gate-to-Source Voltage		$V_{GSop}$	-5/+20	V	
Continuous Drain Current (Note 1)	Steady State	T <sub>C</sub> = 25°C	I <sub>D</sub>	13	Α
Power Dissipation (Note 1)			P <sub>D</sub>	107	W
Continuous Drain Current (Note 1)	Steady State	T <sub>C</sub> = 100°C	I <sub>D</sub>	9.2	Α
Power Dissipation (Note 1)			P <sub>D</sub>	54	W
Pulsed Drain Current (Note 2)	T <sub>C</sub> = 25°C t <sub>p</sub> = 100 μs		I <sub>DM</sub>	45	Α
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C	
Continuous Source Current (Body Diode)			IS	23	Α
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L(pk)</sub> = 11.9 A, L = 1 mH) (Note 3)			E <sub>AS</sub>	71	mJ
Maximum Lead Temperature for Soldering (1/25" from case for 10 s)		TL	270	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Single pulse, limited by max junction temperature.
- 3. EAS of 71 mJ is based on starting  $T_J = 25^{\circ}C$ ; L = 1 mH,  $I_{AS} = 11.9$  A,  $V_{DD} = 120 \text{ V}, V_{GS} = 18 \text{ V}.$

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX	
1700 V	290 mΩ @ 20 V	13 A	



**N-CHANNEL MOSFET** 



#### MARKING DIAGRAM



H4L200N170M1 = Specific Device Code

= Assembly Location

= Year WW = Work Week ΖZ = Lot Traceability

#### ORDERING INFORMATION

Device	Package	Shipping
NVH4L200N170M1	TO-247-4L	30 Units / Tube

#### THERMAL CHARACTERISTICS

Parameter	Symbol	Max	Unit
Junction-to-Case - Steady State (Note 1)	$R_{\theta JC}$	1.4	°C/W

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	1700	-	-	V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>	I <sub>D</sub> = 1 mA, referenced to 25°C	-	0.5	-	V/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 1700 V, T <sub>J</sub> = 25°C	-	_	100	μΑ
		V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 1700 V, T <sub>J</sub> = 175°C (Note 5)	-	-	1	mA
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> = +25/-15 V, V <sub>DS</sub> = 0 V	i	-	±1	μΑ
ON CHARACTERISTICS (Note 2)						
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}$ , $I_D = 2.6 \text{ mA}$	1.8	3.1	4.3	V
Recommended Gate Voltage	$V_{GOP}$		-5	_	+20	V
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$V_{GS} = 20 \text{ V}, I_D = 8.5 \text{ A}, T_J = 25^{\circ}\text{C}$	-	192	290	mΩ
		V <sub>GS</sub> = 20 V, I <sub>D</sub> = 8.5 A, T <sub>J</sub> = 175°C (Note 5)	-	414	-	
Forward Transconductance	9FS	V <sub>DS</sub> = 20 V, I <sub>D</sub> = 8.5 A (Note 5)	-	4.6	-	S
CHARGES, CAPACITANCES & GATE RES	ISTANCE					
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 1000 V	-	596	_	pF
Output Capacitance	C <sub>OSS</sub>	(Note 5)	-	33	_	
Reverse Transfer Capacitance	C <sub>RSS</sub>	1	-	2.5	_	
Total Gate Charge	$Q_{G(TOT)}$	$V_{GS} = -5/20 \text{ V}, V_{DS} = 1000 \text{ V},$	-	31	-	nC
Gate-to-Source Charge	$Q_{GS}$	I <sub>D</sub> = 8.5 A (Note 5)	-	9.1	-	
Gate-to-Drain Charge	$Q_{GD}$		-	7.8	-	
Gate-Resistance	$R_{G}$	f = 1 MHz	-	4.1	-	Ω
SWITCHING CHARACTERISTICS						
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS} = -5/20 \text{ V}, V_{DS} = 1200 \text{ V},$	-	7.7	-	ns
Rise Time	t <sub>r</sub>	$I_D$ = 8.5 A, $R_G$ = 2 $\Omega$ inductive load	ı	8	-	
Turn-Off Delay Time	t <sub>d(OFF)</sub>	(Note 4) and (Note 5)	1	13	-	
Fall Time	t <sub>f</sub>		-	26	-	
Turn-On Switching Loss	E <sub>ON</sub>		-	261	-	μJ
Turn-Off Switching Loss	E <sub>OFF</sub>		-	50	-	
Total Switching Loss	E <sub>tot</sub>		-	311	-	
SOURCE-DRAIN DIODE CHARACTERIST	ics					
Continuous Source-Drain Diode Forward Current	I <sub>SD</sub>	V <sub>GS</sub> = -5 V, T <sub>J</sub> = 25°C	ı	-	23	Α
Pulsed Source-Drain Diode Forward Current (Note 2)	I <sub>SDM</sub>		1	-	79	
Forward Diode Voltage	$V_{SD}$	$V_{GS} = -5 \text{ V}, I_{SD} = 8.5 \text{ A}, T_{J} = 25^{\circ}\text{C}$	-	4.3	-	V
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = -5/20 \text{ V}, I_{SD} = 8.5 \text{ A},$	1	14	-	ns
Reverse Recovery Charge	$Q_{RR}$	dI <sub>S</sub> /dt = 1000 A/μs (Note 5)	-	75	-	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. EON / EOFF result is with body diode.

5. Defined by design, not subject to production.

#### TYPICAL CHARACTERISTICS

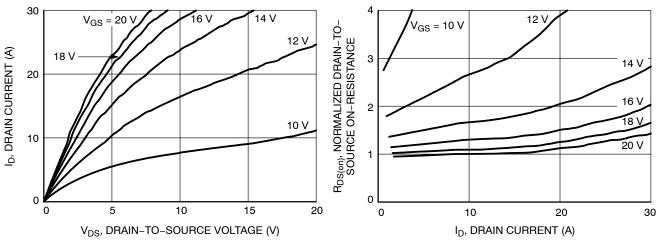


Figure 1. On-Region Characteristics

Figure 2. Normalized On–Resistance vs. Drain Current and Gate Voltage

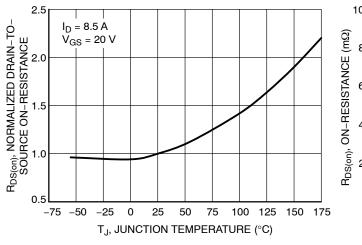


Figure 3. On–Resistance Variation with Temperature

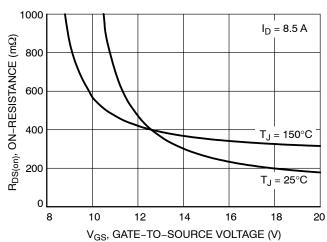


Figure 4. On-Resistance vs. Gate-to-Source Voltage

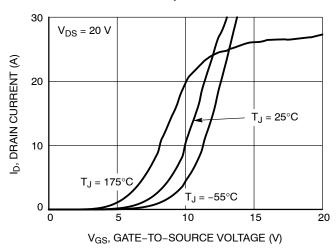


Figure 5. Transfer Characteristics

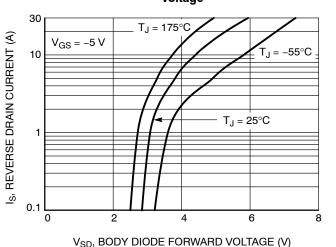


Figure 6. Diode Forward Voltage vs. Current

# **TYPICAL CHARACTERISTICS**

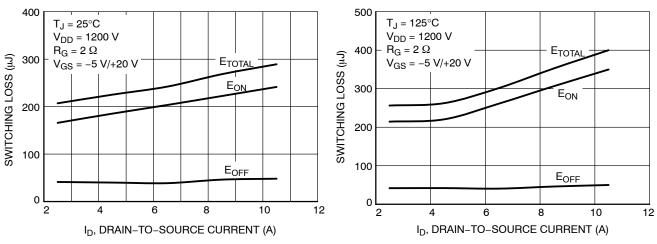


Figure 7. Switching Loss vs. Drain-to-Source Current (25°C)

Figure 8. Switching Loss vs. Drain-to-Source Current (125°C)

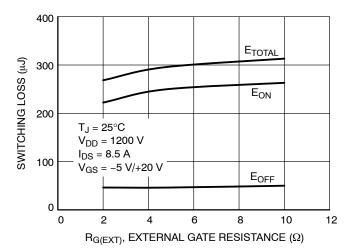
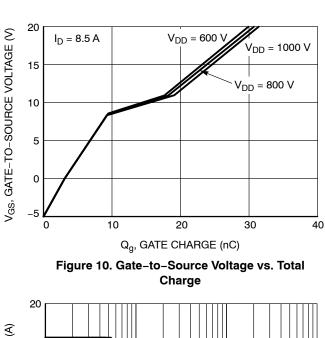


Figure 9. Switching Loss vs. External Gate Resistance

#### **TYPICAL CHARACTERISTICS**



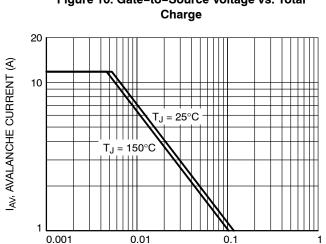


Figure 12. Unclamped Inductive Switching Capability

t<sub>AV</sub>, TIME IN AVALANCHE (ms)

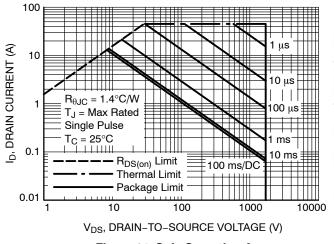


Figure 14. Safe Operating Area

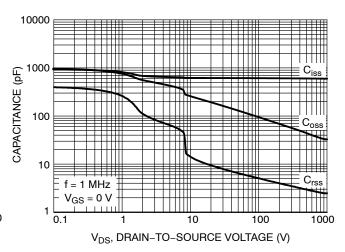


Figure 11. Capacitance vs. Drain-to-Source Voltage

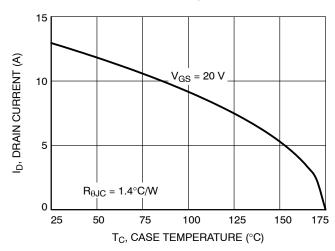


Figure 13. Maximum Continuous Drain Current vs. Case Temperature

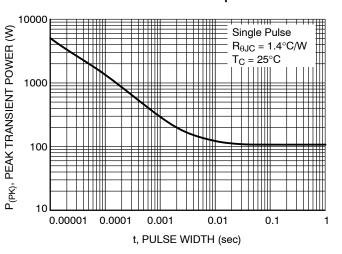


Figure 15. Single Pulse Maximum Power Dissipation

# **TYPICAL CHARACTERISTICS**

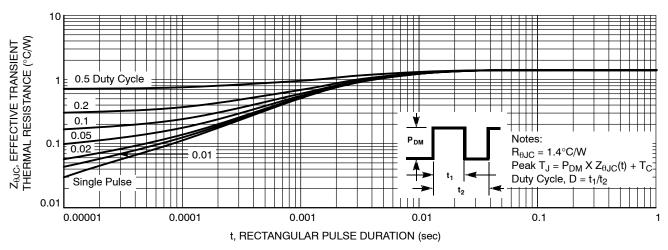


Figure 16. Junction-to-Case Thermal Response

Ø**p1** 

D1

DIM

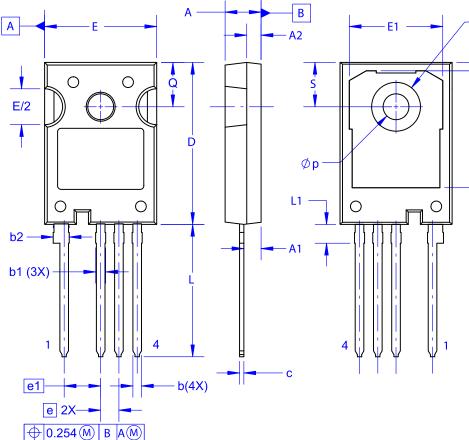
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- D2



#### TO-247-4LD CASE 340CJ **ISSUE A**

**DATE 16 SEP 2019** 



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2.10	2.40	2.70
1.80	2.00	2.20
1.07	1.20	1.33
1.20	1.40	1.60
2.02	2.22	2.42
0.50	0.60	0.70
22.34	22.54	22.74
16.00	16.25	16.50
0.97	1.17	1.37
2.54 BSC		
5.08 BSC		
15.40	15.60	15.80
12.80	13.00	13.20
4.80	5.00	5.20
18.22	18.42	18.62
2.42	2.62	2.82
3.40	3.60	3.80
6.60	6.80	7.00
5.97	6.17	6.37
	1.80 1.07 1.20 2.02 0.50 22.34 16.00 0.97 15.40 12.80 4.80 18.22 2.42 3.40 6.60	1.80         2.00           1.07         1.20           1.20         1.40           2.02         2.22           0.50         0.60           22.34         22.54           16.00         16.25           0.97         1.17           2.54 BSG           5.08 BSG           15.40         15.60           12.80         13.00           4.80         5.00           18.22         18.42           2.42         2.62           3.40         3.60           6.60         6.80

**MILLIMETERS** 

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